

PEWA Messtechnik GmbH

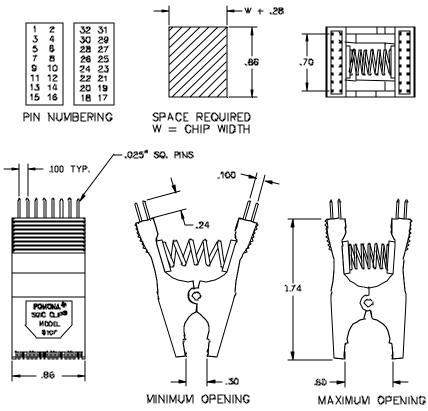
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Model 6107 32 Pin SOIC Clip® Test Clip Lead Spacing: 0.050'' (1,27)

These new test clips are designed especially for in-circuit testing on 32 pin Small Outline Integrated Circuits (SOIC & SOJ). The SOIC Clip® test clip assures a positive connection to all chip leads and provides hands-free testing.

- Upper contacts are .025" ((0,63)sq. pins on 0.100" (2,54) centers. Pins are perfect for sq. pin receptacles, wire-wrap or soldered wires.
- Gold plated upper contacts fit standard double row ribbon cable connectors.
- Gold plated lower contacts assure reliable, noise free connections.



- Molded barriers between each contact allow connections to be made on live boards without accidental shorting to adjacent chip leads.
- Open back of clip allows probing of chip leads while the clip is attached.
- Fits all 32 pin surface mounted SOIC and SOJ chips from .30" (7,62) to .60" (15,24) wide.
- Compact design requires a minimum of board space. Clips can be placed on chips that are spaced only .040" (1,02) apart, end-to-end. The clip requires .14" (3,56) beyond each side of the chip for placement.

All dimensions are in inches. Tolerances (except noted): $xx = \pm.02^{\circ}$ (,51 mm), $xxx = \pm.005^{\circ}$ (,127 mm). All specifications are to the latest revisions. Specifications are subject to change without notice. Registered trademarks are the property of their respective companies. Made in USA